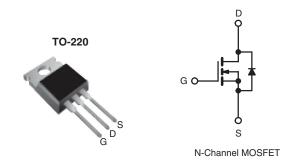


Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	60	60				
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.028				
Q _g (Max.) (nC)	67	•				
Q _{gs} (nC)	18	}				
Q _{gd} (nC)	25	25				
Configuration	Sing	Single				



FEATURES

- · Dynamic dV/dt Rating
- 175 °C Operating Temperature
- · Fast Switching
- · Ease of Paralleling
- · Simple Drive Requirements
- Lead (Pb)-free Available



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universially preferred for commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220		
Load (Dh) free	IRFZ44PbF		
Lead (Pb)-free	SiHFZ44-E3		
SnPb	IRFZ44		
SIIFD	SiHFZ44		

ABSOLUTE MAXIMUM RATINGS To	_C = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	60	V	
Gate-Source Voltage			V_{GS}	± 20	1 v	
Continuous Drain Currente	\/ at 10 \/	T _C = 25 °C	- I _D	50		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C		36	Α	
Pulsed Drain Current ^a			I _{DM}	200		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	100	mJ	
Maximum Power Dissipation	T _C =	25 °C	P _D	150	W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	00	
Soldering Recommendations (Peak Temperature) ^d	for 10 s			300	- °C	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 44 μ H, R_G = 25 Ω , I_{AS} = 51 A (see fig. 12).
- c. $I_{SD} \le 51$ A, $dI/dt \le 250$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.
- e. Current limited by the package, (die current = 51 A).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

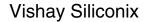


THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.060	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$		· V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I_{GSS}		$V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		V _{DS} = 60 V, V _{GS} = 0 V V _{DS} = 48 V, V _{GS} = 0 V, T _J = 125 °C		-	25 250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 31 A ^b	-	-	0.028	Ω
Forward Transconductance	9fs	V _{DS}	= 25 V, I _D = 31 A	15	-	-	S
Dynamic		•					
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	1900	-	pF
Output Capacitance	C _{oss}			-	920	-	
Reverse Transfer Capacitance	C _{rss}			-	170	-	
Total Gate Charge	Qg	V _{GS} = 10 V		-	-	67	nC
Gate-Source Charge	Q _{gs}		$I_D = 51 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13^b	-	-	18	
Gate-Drain Charge	Q_{gd}			-	-	25	
Turn-On Delay Time	$t_{d(on)}$			-	14	-	- ns
Rise Time	t _r	V _{DD} :	V _{DD} = 30 V, I _D = 51 A,		110	-	
Turn-Off Delay Time	$t_{d(off)}$	$R_G = 9.1 \Omega$, $R_D = 0.55 \Omega$, see fig. 10^b		-	45	-	
Fall Time	t _f			-	92	-	
Internal Drain Inductance	L_D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	ml I
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s			•	•	•	
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	50	- A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	200	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 51 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 51 A, dI/dt = 100 A/μs		-	120	180	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.53	0.80	nC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

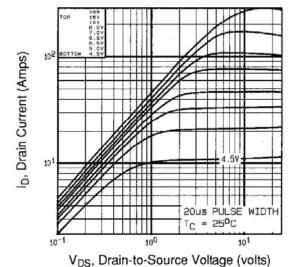
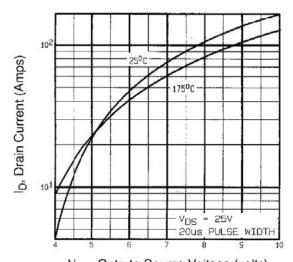
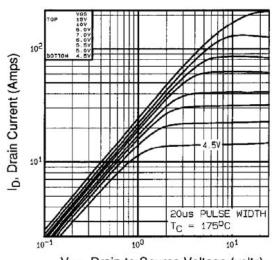


Fig. 1 - Typical Output Characteristics, T_C = 25 °C



V_{GS}, Gate-to-Source Voltage (volts) Fig. 3 - Typical Transfer Characteristics



 V_{DS} , Drain-to-Source Voltage (volts) Fig. 2 - Typical Output Characteristics, T_C = 175 °C

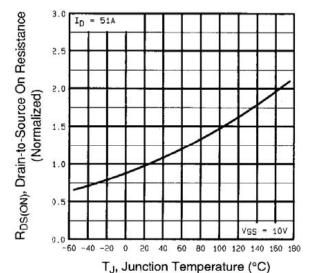


Fig. 4 - Normalized On-Resistance vs. Temperature



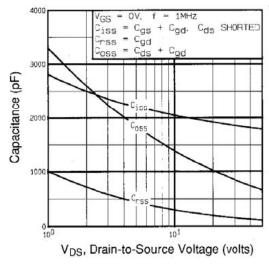


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

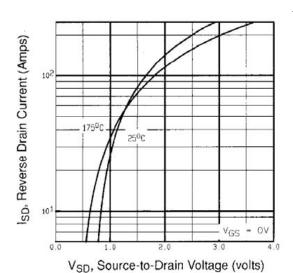


Fig. 7 - Typical Source-Drain Diode Forward Voltage

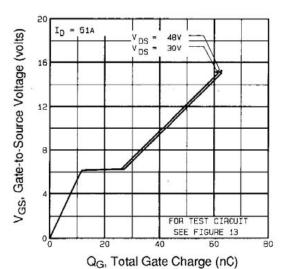


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

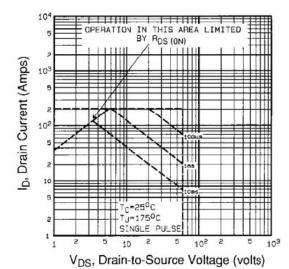


Fig. 8 - Maximum Safe Operating Area





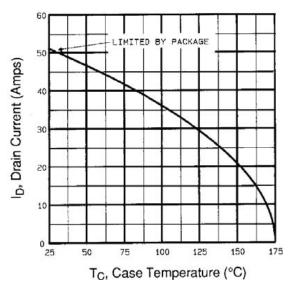


Fig. 9 - Maximum Drain Current vs. Case Temperature

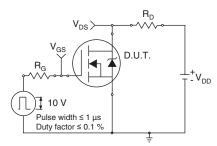


Fig. 10a - Switching Time Test Circuit

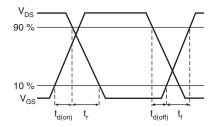


Fig. 10b - Switching Time Waveforms

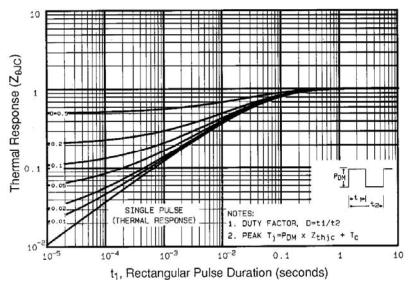


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

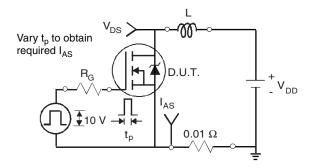


Fig. 12a - Unclamped Inductive Test Circuit

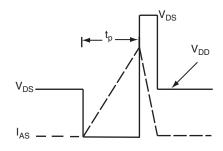


Fig. 12b - Unclamped Inductive Waveforms



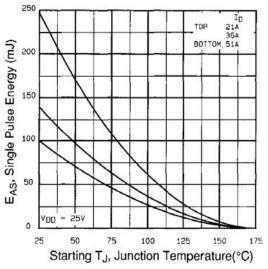


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

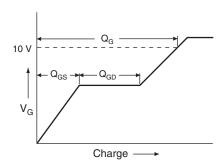


Fig. 13a - Basic Gate Charge Waveform

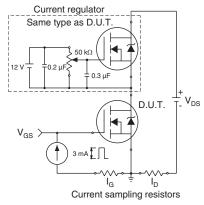
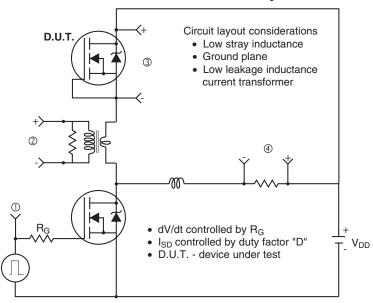
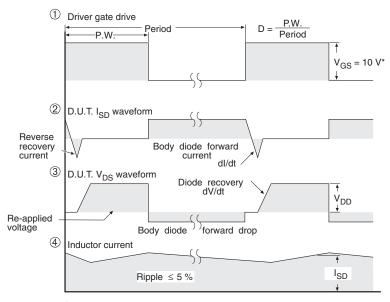


Fig. 13b - Gate Charge Test



Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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